

**G6401****P-CHANNEL ENHANCEMENT MODE POWER MOSFET**

|         |       |
|---------|-------|
| BVDSS   | -12V  |
| RDS(ON) | 50mΩ  |
| ID      | -4.3A |

**Description**

The G6401 provides the designer with the best combination of fast switching, low on-resistance and cost-effectiveness.

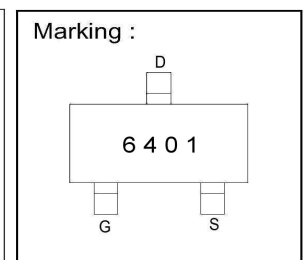
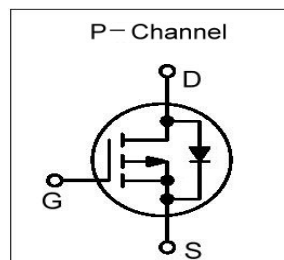
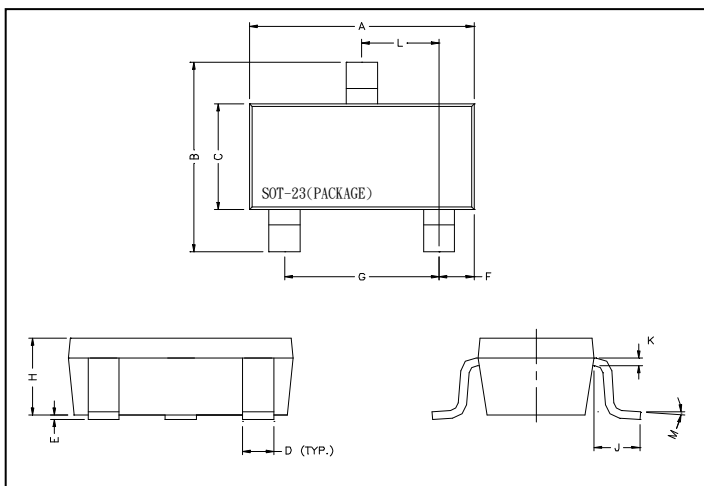
The G6401 is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

**Features**

- Ultra Low  $R_{DS(ON)}$
- Fast Switching
- 1.8V Gate Rated

**Applications**

- Power Management in Notebook Computer
- Portable Equipment
- Battery Powered System.

**Package Dimensions**

| REF. | Millimeter |      | REF. | Millimeter |      |
|------|------------|------|------|------------|------|
|      | Min.       | Max. |      | Min.       | Max. |
| A    | 2.70       | 3.10 | G    | 1.90       | REF. |
| B    | 2.40       | 2.80 | H    | 1.00       | 1.30 |
| C    | 1.40       | 1.60 | K    | 0.10       | 0.20 |
| D    | 0.35       | 0.50 | J    | 0.40       | -    |
| E    | 0          | 0.10 | L    | 0.85       | 1.15 |
| F    | 0.45       | 0.55 | M    | 0°         | 10°  |

**Absolute Maximum Ratings**

| Parameter                                        | Symbol                       | Ratings    | Unit |
|--------------------------------------------------|------------------------------|------------|------|
| Drain-Source Voltage                             | $V_{DS}$                     | -12        | V    |
| Gate-Source Voltage                              | $V_{GS}$                     | $\pm 8$    | V    |
| Continuous Drain Current <sup>3</sup>            | $I_D @ T_A=25^\circ\text{C}$ | -4.3       | A    |
| Continuous Drain Current <sup>3</sup>            | $I_D @ T_A=70^\circ\text{C}$ | -3.4       | A    |
| Pulsed Drain Current <sup>1</sup>                | $I_{DM}$                     | -12        | A    |
| Power Dissipation                                | $P_D @ T_A=25^\circ\text{C}$ | 1.38       | W    |
| Linear Derating Factor                           |                              | 0.01       | W/°C |
| Operating Junction and Storage Temperature Range | $T_j, T_{stg}$               | -55 ~ +150 | °C   |

**Thermal Data**

| Parameter                                             | Symbol      | Ratings | Unit |
|-------------------------------------------------------|-------------|---------|------|
| Thermal Resistance Junction-ambient <sup>3</sup> Max. | $R_{thj-a}$ | 90      | °C/W |

## Electrical Characteristics( $T_j = 25^\circ\text{C}$ Unless otherwise specified)

| Parameter                                              | Symbol                       | Min. | Typ.  | Max.      | Unit                | Test Conditions                                     |
|--------------------------------------------------------|------------------------------|------|-------|-----------|---------------------|-----------------------------------------------------|
| Drain-Source Breakdown Voltage                         | $BV_{DSS}$                   | -12  | -     | -         | V                   | $V_{GS}=0, I_D=-250\mu\text{A}$                     |
| Breakdown Voltage Temperature Coefficient              | $\Delta BV_{DSS}/\Delta T_j$ | -    | -0.01 | -         | V/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}$ , $I_D=-1\text{mA}$ |
| Gate Threshold Voltage                                 | $V_{GS(th)}$                 | -    | -     | -1.0      | V                   | $V_{DS}=V_{GS}, I_D=-250\mu\text{A}$                |
| Forward Transconductance                               | $g_{fs}$                     | -    | 12    | -         | S                   | $V_{DS}=-5.0\text{V}, I_D=-4.0\text{A}$             |
| Gate-Source Leakage Current                            | $I_{GSS}$                    | -    | -     | $\pm 100$ | nA                  | $V_{GS}=\pm 8\text{V}$                              |
| Drain-Source Leakage Current( $T_j=25^\circ\text{C}$ ) | $I_{DSS}$                    | -    | -     | -1        | $\mu\text{A}$       | $V_{DS}=-16\text{V}, V_{GS}=0$                      |
| Drain-Source Leakage Current( $T_j=70^\circ\text{C}$ ) |                              | -    | -     | -25       | $\mu\text{A}$       | $V_{DS}=-12\text{V}, V_{GS}=0$                      |
| Static Drain-Source On-Resistance <sup>2</sup>         | $R_{DS(ON)}$                 | -    | -     | 50        | $\text{m}\Omega$    | $V_{GS}=-4.5\text{V}, I_D=-4.3\text{A}$             |
|                                                        |                              | -    | -     | 85        |                     | $V_{GS}=-2.5\text{V}, I_D=-2.5\text{A}$             |
|                                                        |                              | -    | -     | 125       |                     | $V_{GS}=-1.8\text{V}, I_D=-2.0\text{A}$             |
| Total Gate Charge <sup>2</sup>                         | $Q_g$                        | -    | 15    | 24        | nC                  | $I_D=-4.0\text{A}$                                  |
| Gate-Source Charge                                     | $Q_{gs}$                     | -    | 1.3   | -         |                     | $V_{DS}=-12\text{V}$                                |
| Gate-Drain ("Miller") Charge                           | $Q_{gd}$                     | -    | 4     | -         |                     | $V_{GS}=-4.5\text{V}$                               |
| Turn-on Delay Time <sup>2</sup>                        | $T_{d(on)}$                  | -    | 8     | -         | ns                  | $V_{DS}=-10\text{V}$                                |
| Rise Time                                              | $T_r$                        | -    | 11    | -         |                     | $I_D=-1\text{A}$                                    |
| Turn-off Delay Time                                    | $T_{d(off)}$                 | -    | 54    | -         |                     | $V_{GS}=-10\text{V}$                                |
| Fall Time                                              | $T_f$                        | -    | 36    | -         |                     | $R_G=3.3\Omega$<br>$R_D=10\Omega$                   |
| Input Capacitance                                      | $C_{iss}$                    | -    | 985   | 1580      | pF                  | $V_{GS}=0\text{V}$                                  |
| Output Capacitance                                     | $C_{oss}$                    | -    | 180   | -         |                     | $V_{DS}=-15\text{V}$                                |
| Reverse Transfer Capacitance                           | $C_{rss}$                    | -    | 160   | -         |                     | $f=1.0\text{MHz}$                                   |

## Source-Drain Diode

|                                    |          |   |    |      |    |                                 |
|------------------------------------|----------|---|----|------|----|---------------------------------|
| Forward On Voltage <sup>2</sup>    | $V_{SD}$ | - | -  | -1.2 | V  | $I_S=-1.2\text{A}, V_{GS}=0$    |
| Reverse Recovery Time <sup>2</sup> | $T_{rr}$ | - | 39 | -    | ns | $I_S=-4.0\text{A}, V_{GS}=0$    |
| Reverse Recovery Charge            | $Q_{rr}$ | - | 26 | -    | nC | $dI/dt=100\text{A}/\mu\text{s}$ |

Notes: 1. Pulse width limited by Max. junction temperature.

2. Pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$ .

3. Surface mounted on 1 in<sup>2</sup> copper pad of FR4 board;  $270^\circ\text{C}/\text{W}$  when mounted on min. copper pad.

## Characteristics Curve

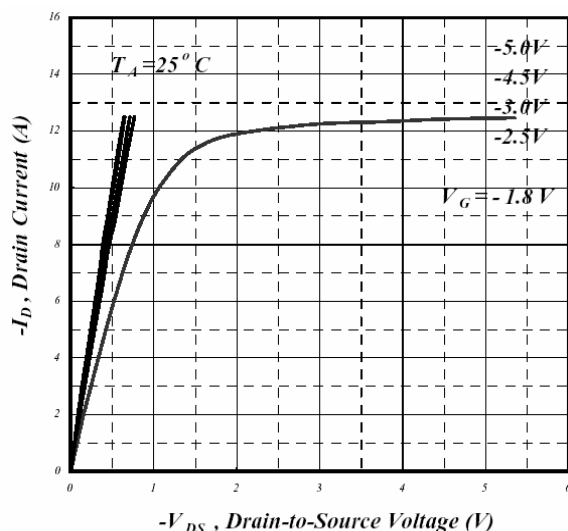


Fig 1. Typical Output Characteristics

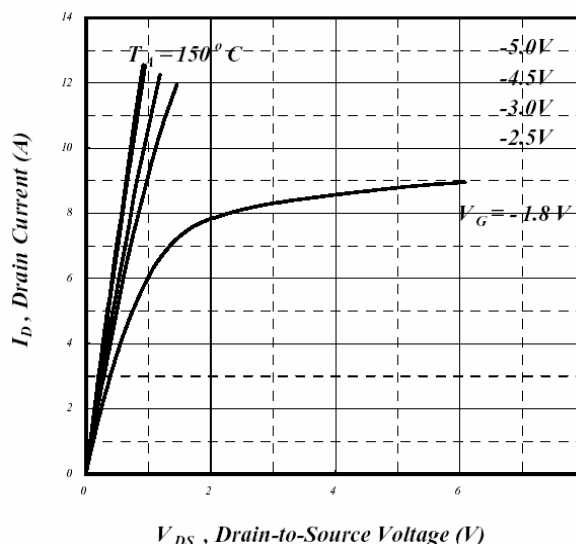
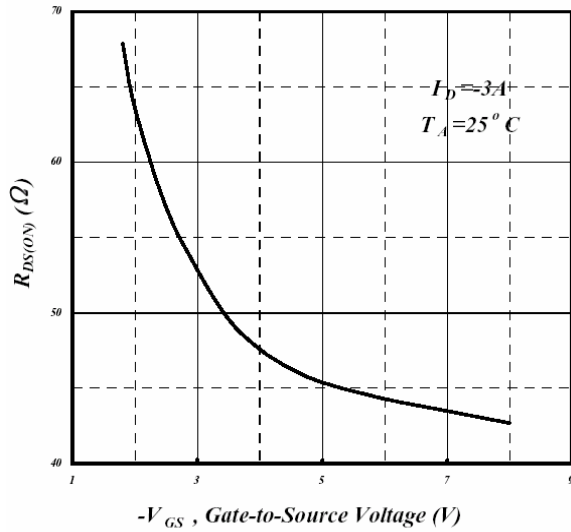
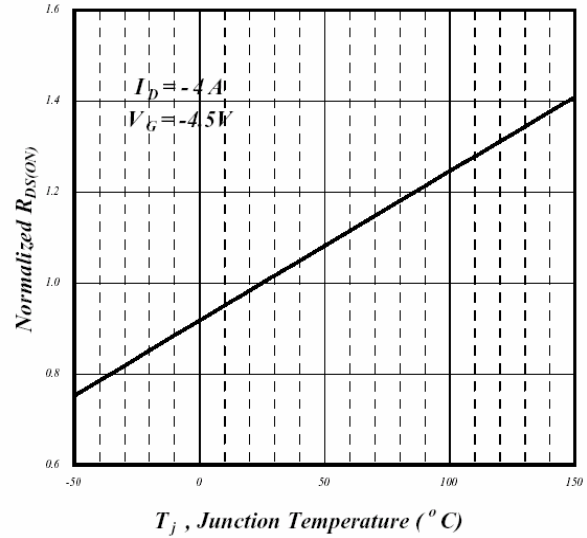


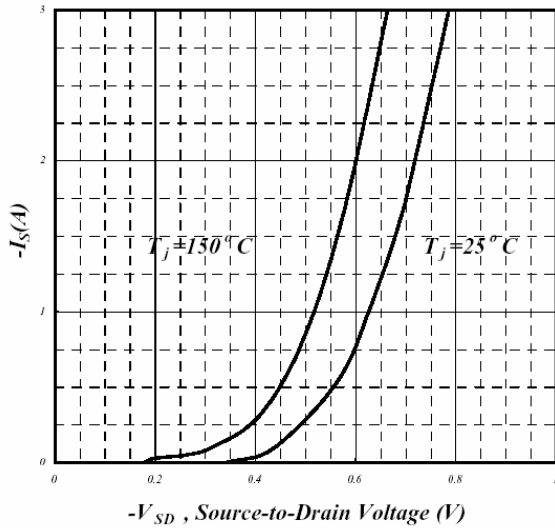
Fig 2. Typical Output Characteristics



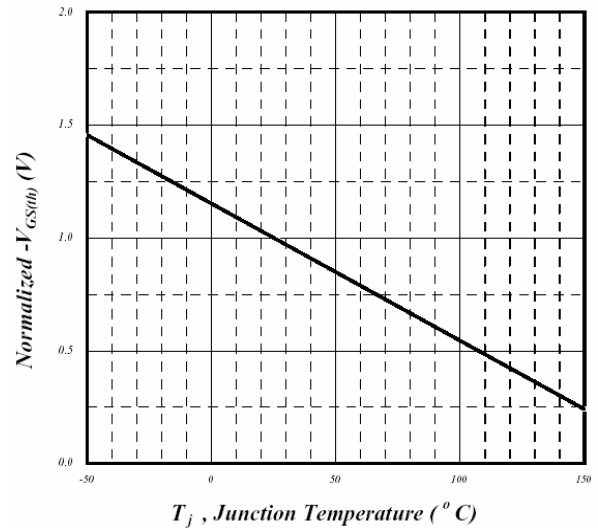
**Fig 3. On-Resistance v.s. Gate Voltage**



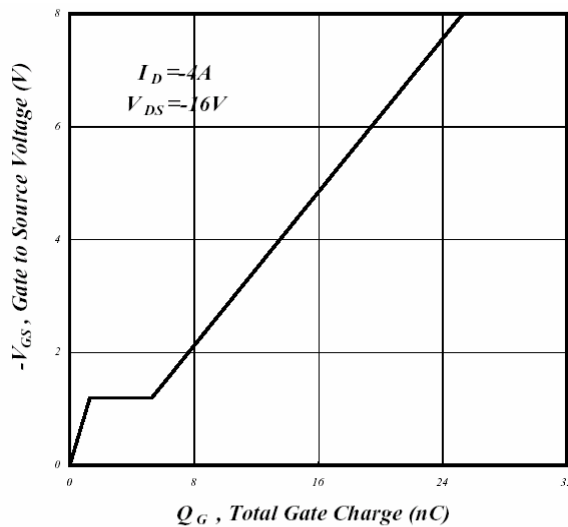
**Fig 4. Normalized On-Resistance v.s. Junction Temperature**



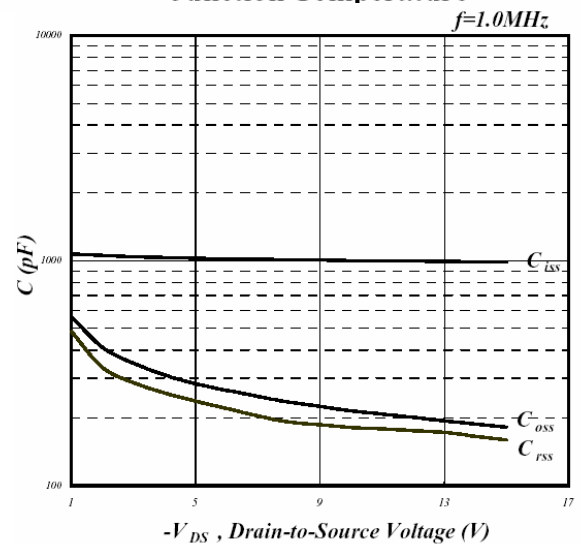
**Fig 5. Forward Characteristic of Reverse Diode**



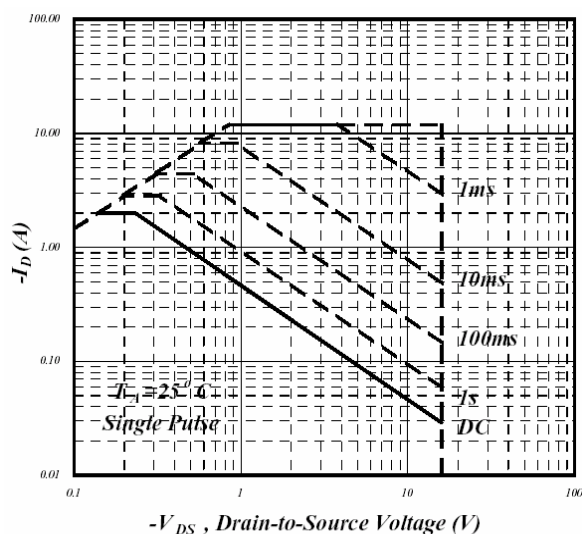
**Fig 6. Gate Threshold Voltage v.s. Junction Temperature**



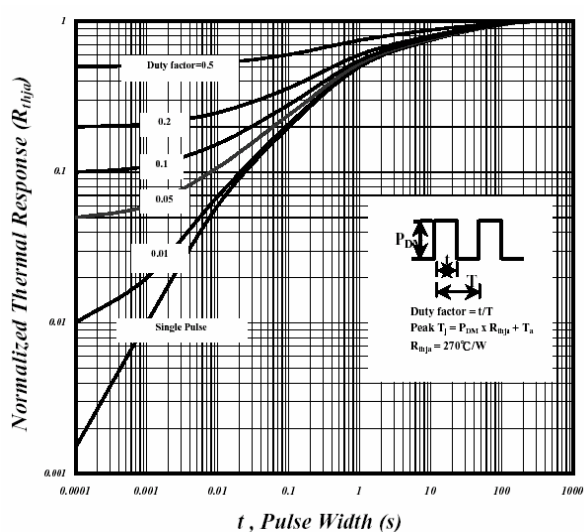
**Fig 7. Gate Charge Characteristics**



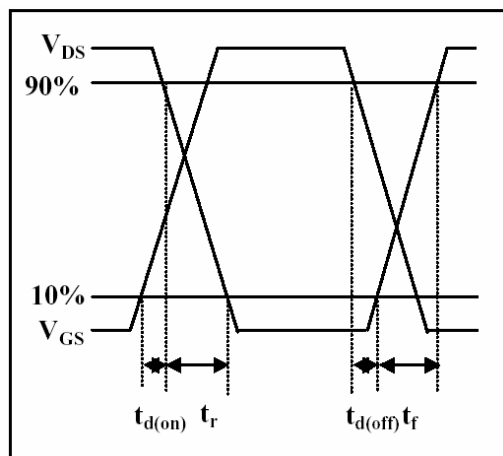
**Fig 8. Typical Capacitance Characteristics**



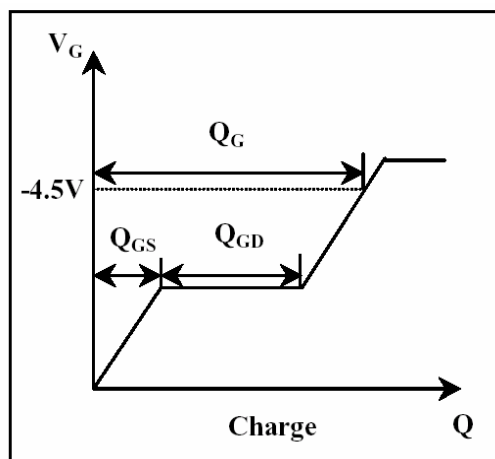
**Fig 9. Maximum Safe Operating Area**



**Fig 10. Effective Transient Thermal Impedance**



**Fig 11. Switching Time Waveform**



**Fig 12. Gate Charge Waveform**

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